Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,754	MEIER ET AL.	
Examiner	Art Unit	
Daniel Kim	2185	

SEARCHED			
Class	Subclass	Date	Examiner
711	128	6/10/2007	DK
711	118, 133	6/10/2007	DK
365	49, 50	6/10/2007	DK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
EAST Search	6/10/2007	DK
Inventor Name Search for DP	6/10/2007	DK
IEEE Search	6/10/2007	DK
ACM Search	6/10/2007	DK
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